

**Notice of References Cited**

Application/Control No.

10/763,220

Applicant(s)/Patent Under  
Reexamination  
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Examiner

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Art Unit

2625

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,777,624 A	07-1998	Munson, Bill A.	345/605
*	B	US-5,991,511 A	11-1999	Granger, Edward M.	358/1.9
*	C	US-2002/0196346 A1	12-2002	Nishio et al.	348/207.2
*	D	US-2003/0052894 A1	03-2003	Akiyama et al.	345/589
*	E	US-2004/0114159 A1	06-2004	Couwenhoven et al.	358/001.9
*	F	US-2004/0252906 A1	12-2004	Liege et al.	382/254
*	G	US-7,158,670 B1	01-2007	Fushiki et al.	382/167
*	H	US-2007/0133026 A1	06-2007	Kumada et al.	358/001.9
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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